



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. 10/757,252
Filing Date January 13, 2004
Inventor Denise M. Eppich et al.
Assignee Micron Technology, Inc.
Group Art Unit 2815
Examiner Jesse A. Fenty
Attorney's Docket No. MI22-2468
Customer No. 021567
Title: CMOS Constructions

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Reference - - See attached Form PTO-1449

The attached Form PTO-1449 is submitted in compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the references listed on the attached Form PTO-1449. Pursuant to Federal Register Vol. 69, No. 182, pg. 56542 (September 21, 2004), no copies of any cited U.S. patents or U.S. published applications are included herewith. Copies of all other cited art references, if any, are attached. No admission is made regarding whether the submitted references are prior art.

Citation of this reference is respectfully requested.

Respectfully submitted,

Date: 1-26-06

D. Brent Kenady
Reg. No. 40,045
Customer No. 021567

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Form PTO-1449

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U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	6,214,724 B1	04/01	Kazuaki Nakajima	438	656	
	AB	6,297,539 B1	10/01	Ma et al.	257	410	
	AC						
	AD						
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FOREIGN PATENT DOCUMENTS

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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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